

3.0-3.6 GHz Wideband, over 46% Average Efficiency GaN Doherty Power Amplifier with Frequency Dependency Compensating Circuits

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Abstract — A wideband GaN Doherty power amplifier (DPA) for 4G/LTE-Advanced base stations is presented. To break the inherent narrow band limitation of conventional DPA, a frequency dependency compensating circuit and a modified $\lambda/4$ inverter incorporating package parasitic elements are proposed. Measured DPA achieves 45.9-50.2 % drain efficiency with -50 dBc ACLR at 3.0-3.6 GHz under 20 MHz LTE signal after digital pre-distortion (DPD), which is very suitable for multiband radio and carrier aggregation in 4G. The use of the wideband efficient GaN DPA can reduce the complexity and energy consumption of radio, which further helps reducing the total cost of ownership (TCO) of base stations.

Index Terms — wideband, Doherty amplifier, GaN HEMT, base station, power amplifier.

I. INTRODUCTION

Recently, wireless communication systems apply high peak to average power ratio (PAPR) signals to cope with crowded spectrum and faster data speed demand. RF power amplifiers for base station require high efficiency at a large back-off level. To efficiently amplify greater PAPR signals (>7dB) at frequency above 3 GHz, GaN Doherty power amplifier (DPA) is preferred over LDMOS technology due to its unique advantages [1], [2].

Moreover, there is also an increasing demand for expanding the bandwidth of the DPA to cover multiband of 4G/LTE-Advanced [3]. However, the DPA is fundamentally limited to narrow frequency range due to the frequency dependent $\lambda/4$ inverter for load modulation.

This work proposes a 3.0-3.6 GHz wideband GaN DPA with novel frequency dependency compensating circuit. The proposed compensating circuit compensates frequency dependence of the $\lambda/4$ inverter mentioned above, and it works as an inductive or a capacitive reactance depending on the frequency. In addition, an output configuration absorbing both transistor's output capacitance (C_{ds}) and reactance of package into a part of the $\lambda/4$ inverter is applied. The advantages of the proposed

GaN DPA configuration are clearly demonstrated by the outperformed performance.

II. CIRCUIT CONFIGURATION OF WIDEBAND DPA

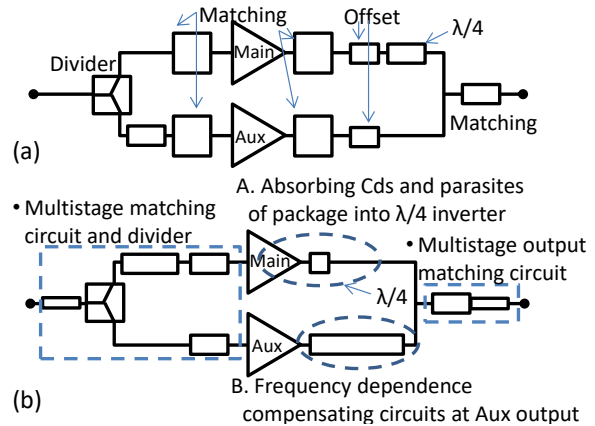


Fig. 1. Schematics of DPAs. (a) Conventional, (b) Proposed.

Fig. 1(a) and (b) compares the schematics of a conventional and our proposed DPA. In conventional DPA, matching circuits are connected at output of the main amplifier (Main) and auxiliary amplifier (Aux). The offset lines, which adjust the phase to realize correct resistive load modulation of a Main, are connected after the matching circuits. On the other hand, as shown in Fig 1(b), the proposed DPA doesn't include matching circuits and offset line, and the $\lambda/4$ inverter is directly connected to the equivalent current source plane of a transistor (see A in Fig. 1(b)). In addition, the frequency dependency compensating circuit is applied to an output of Aux (see B in Fig. 1(b)). In this section, the operation principles of the two key features are shown, respectively.

A. Absorbing transistor's C_{ds} and reactance of package into a part of the $\lambda/4$ inverter

The concept of absorbing device capacitance and reactance of package into a part of the $\lambda/4$ (90 degree)

inverter is shown in Fig. 2. The goal is to mimic the same center frequency response as the ideal $\lambda/4$ transmission line by using transistor's C_{ds} , reactance of package and additional component at outside of package. The characteristic impedance Z_c is arbitrary, and the $\lambda/4$ inverter can operate as the impedance transformer under the conditions both saturation region and back-off region. In most cases of the conventional DPA, the electric length from equivalent current source plane of the transistor to combining point of the Main and Aux is more than $\lambda/4$ (e.g. 270, 450 degree) because it includes matching circuits, offset lines and the $\lambda/4$ inverter. Compared with the conventional DPA, the electric length of the proposed DPA is exactly $\lambda/4$ and it can achieve wider bandwidth performance.

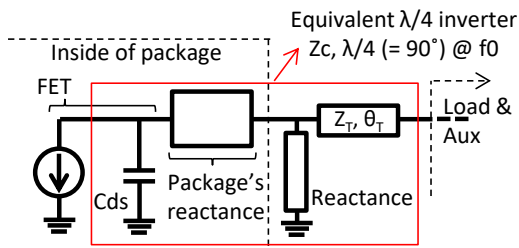


Fig. 2. Schematic of the $\lambda/4$ inverter absorbed transistor output capacitance and reactance of package.

B. Frequency dependency compensating circuit

The concept of the frequency dependency compensating circuit is shown in Fig. 3. The circuit is applied to compensate frequency dependence of the $\lambda/4$ inverter at output of the Main. The compensating circuit is based on a transmission line, transistor's C_{ds} and reactance of the Aux. The electric length from the equivalent current source plane of the transistor in the compensating circuit is $180 \times N$ degree ($N = 1, 2, 3 \dots$), and the electric length and characteristic impedance depend on the frequency dependence of the $\lambda/4$ inverter.

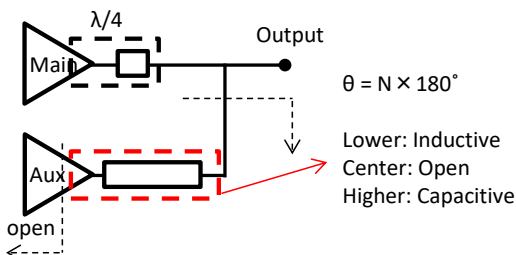


Fig. 3. Schematic of the frequency dependency compensating circuit.

Figure 4 shows the simulated frequency response of reflection at output terminal of DPA. The parameter is electric length in the compensating circuit under the back-off region, and simulations are performed under the conditions of 180×0 , 180×1 and 180×2 degree. The

compensating circuit works as an inductive reactance at lower frequency, and works as a capacitive reactance at higher frequency. In this case, the compensating circuit with 180×2 degree minimizes the frequency dependency of reflection.

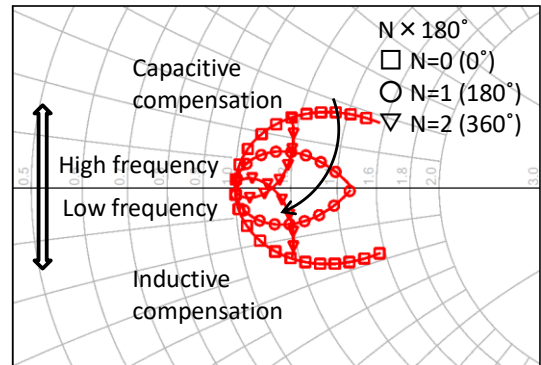


Fig. 4. Simulated frequency response of reflection at output terminal of DPA.

III. MEASURED RESULTS

Figure 5 shows the photo of the assembled wideband GaN DPA with frequency dependency compensating circuit. The DPA is fabricated with MGFS39G38L2 in Mitsubishi Electric, which contains two GaN HEMTs inside one package. In this work, upper one is operated as a Main, and lower one is operated as an Aux. The input and output circuits are fabricated with RO4350B substrates.

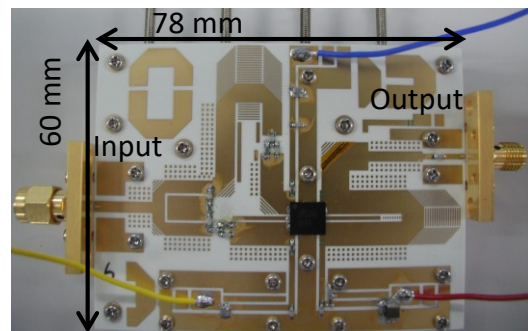


Fig. 5. Photo of the assembled wideband GaN DPA with frequency dependency compensating circuit.

Fig. 6 and 7 show the measured dynamic AM/AM and AM/PM characteristics of the assembled wideband GaN DPA, respectively. The measurements were performed under the conditions of both with and without DPD, and the frequency is 3.4 GHz. The drain voltage is 30 V. An input signal is LTE Downlink, bandwidth of 20 MHz and PAPR of 7.5 dB. The measured results in Fig. 6 and 7 show the improvement of AM/AM and AM/PM characteristics by DPD demonstrating good linearizability.

The measured adjacent channel leakage ratio (ACLR) and drain efficiency (DE) at 3.4 GHz are shown in Fig. 8. The ACLR is defined by the worst case of between lower and upper frequency part of ACLR. As shown in Fig.8, the ACLR with DPD has improvement of 10-15 dB than that without DPD, and the proposed GaN DPA achieved the DE of 47.7 % with ACLR of -50 dBc.

The measured frequency sweep using the same LTE-signal for DE and output power at ACLR of -50dBc with DPD are shown in Fig. 9. Over the 3.0-3.6 GHz frequency band, the proposed GaN DPA obtained the DE of 45.9-50.2 %. The measured results of the fractional bandwidth demonstrated the proposed GaN DPA can cover multi bands for 4G/LTE-Advanced.

A performance comparison of wideband DPAs for LTE bands above 3 GHz is given in Table I. The proposed GaN DPA shows the state-of-the-art performances, and the advantages of the proposed configuration are clearly demonstrated.

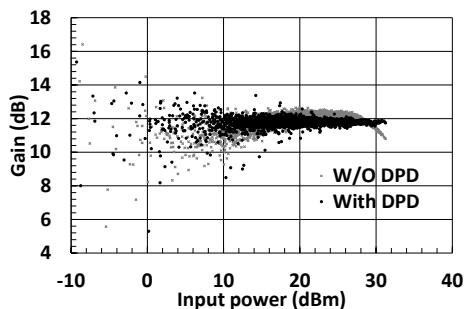


Fig. 6. Measured dynamic AM/AM characteristics at 3.4GHz.

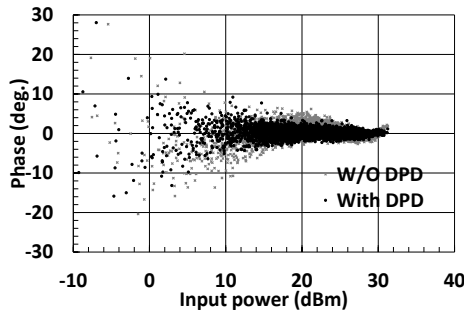


Fig. 7. Measured dynamic AM/PM characteristics at 3.4GHz.

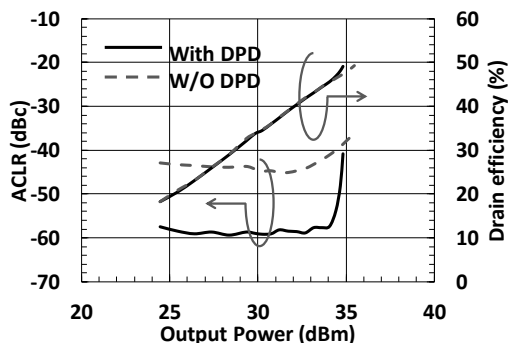


Fig. 8. Measured ACLR and DE at 3.4GHz.

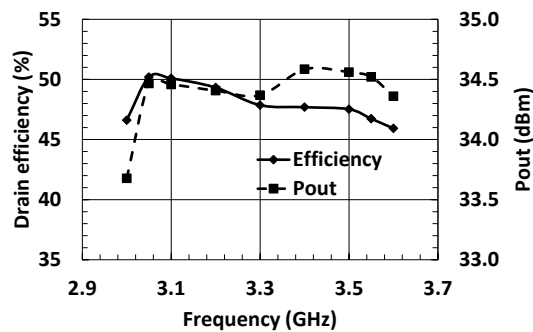


Fig. 9. Measured frequency dependences of DE and output power with ACLR of -50dBc with DPD.

TABLE I.
COMPARISON OF DPAs ABOVE 3GHz LTE BANDS

Ref.	Year	Freq. (GHz)	η (%)	Signal	Condition
[3]	2012	3.0-3.6	38-56	CW	6dB backoff
[1]	2013	3.4-3.5	42.5	5 × 20MHz LTE, DPD	ACLR=-48(dBc)
[2]	2014	3.45-3.55	56	5 × 20MHz LTE, DPD	ACLR=-50(dBc)
T. W.	2016	3.0-3.6	45.9-50.2	20 MHz LTE, DPD	ACLR=-50(dBc)

IV. CONCLUSION

To realize the wideband DPA above 3GHz, the frequency dependency compensating circuit and the $\lambda/4$ inverter incorporating parasitic elements inside package were proposed. The feasibility of the approach was verified by measurement results, and it achieved 45.9-50.2 % drain efficiency with -50 dBc ACLR over the 3.0-3.6 GHz under 20 MHz LTE signal after DPD. The use of the wideband efficient GaN DPA can reduce the complexity and energy consumption of radio, which further helps reducing TCO of base stations.

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